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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use as many sheets as necessary)

Sheet

1

of

1

				Complete if Known
Application Number				10/660,564
Filing Date				September 12, 2003
First Named Inventor				Hiroshi Deguchi
Art Unit				N/A
Examiner Name				Not Yet Assigned
Attorney Docket Number				H6790.0003/P003

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
AA*	US 2003/0214888 A1	11-20-2003	Kato et al.		
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PTO/SB/08a/b (08-03)

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Substitute for form 1449A/B/PTO				Complete if Known	
				Application Number	10/660,564-Conf. #5321
				Filing Date	September 12, 2003
				First Named Inventor	Hiroshi Deguchi
				Art Unit	1772
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	H6790.0003/P003

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